

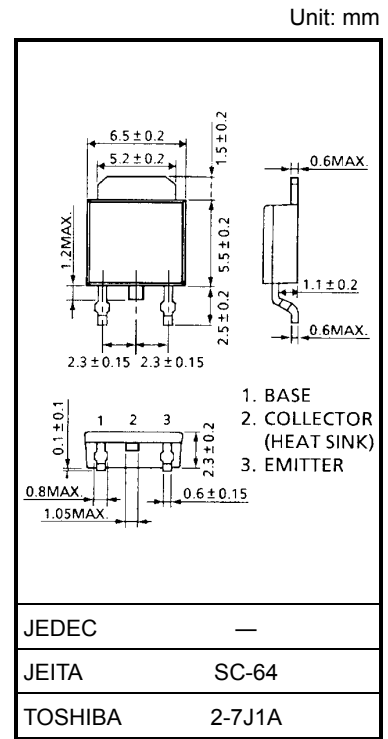
2SA2097

High-Speed Switching Applications
DC-DC Converter Applications

- High DC current gain: $h_{FE} = 200$ to 500 ($I_C = -0.5$ A)
- Low collector-emitter saturation: $V_{CE(sat)} = -0.27$ V (max)
- High-speed switching: $t_f = 55$ ns (typ.)

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Collector-base voltage		V_{CBO}	-50	V
Collector-emitter voltage		V_{CEO}	-50	V
Emitter-base voltage		V_{EBO}	-7	V
Collector current	DC	I_C	-5	A
	Pulse	I_{CP}	-10	
Base current		I_B	-0.5	A
Collector power dissipation	Ta = 25°C	P_c	1	W
	Tc = 25°C		20	
Junction temperature		T_j	150	°C
Storage temperature range		T_{stg}	-55 to 150	°C



Weight: 0.36 g (typ.)

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		I_{CBO}	$V_{CB} = -50$ V, $I_E = 0$	—	—	-100	nA
Emitter cut-off current		I_{EBO}	$V_{EB} = -7$ V, $I_C = 0$	—	—	-100	nA
Collector-emitter brakedown voltage		$V_{(BR)CEO}$	$I_C = -10$ mA, $I_B = 0$	-50	—	—	V
DC current gain		$h_{FE}(1)$	$V_{CE} = -2$ V, $I_C = -0.5$ A	200	—	500	
		$h_{FE}(2)$	$V_{CE} = -2$ V, $I_C = -1.6$ A	100	—	—	
Collector-emitter saturation voltage		$V_{CE(sat)}$	$I_C = -1.6$ A, $I_B = -53$ mA	—	—	-0.27	V
Base-emitter saturation voltage		$V_{BE(sat)}$	$I_C = -1.6$ A, $I_B = -53$ mA	—	—	-1.10	V
Switching time	Rise time	t_r	See Figure 1 circuit diagram $V_{CC} \approx -24$ V, $R_L = 15 \Omega$ $I_{B1} = -I_{B2} = -53$ mA	—	63	—	ns
	Storage time	t_{stg}		—	280	—	
	Fall time	t_f		—	55	—	

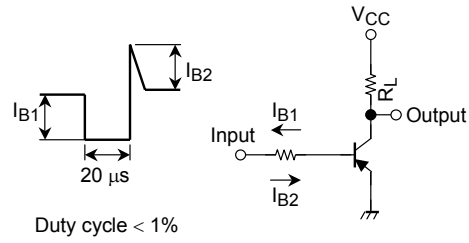
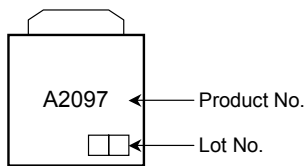
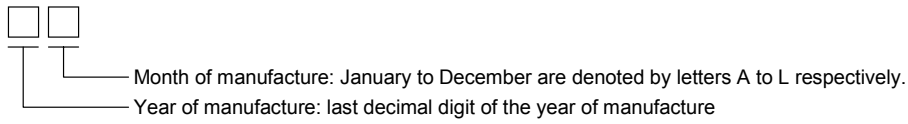


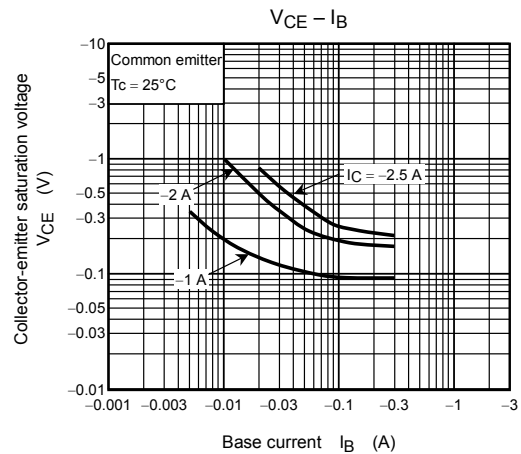
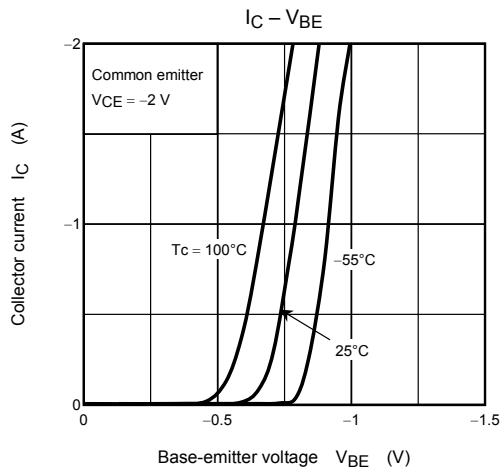
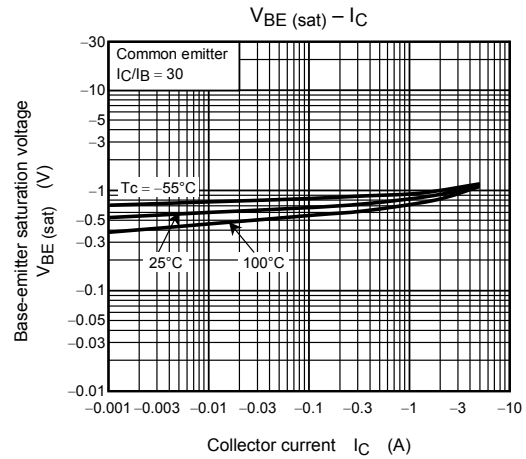
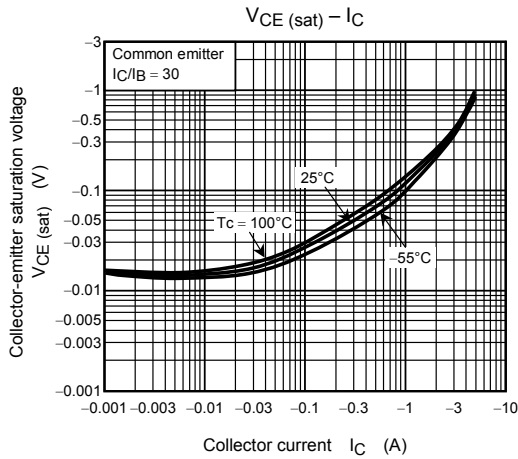
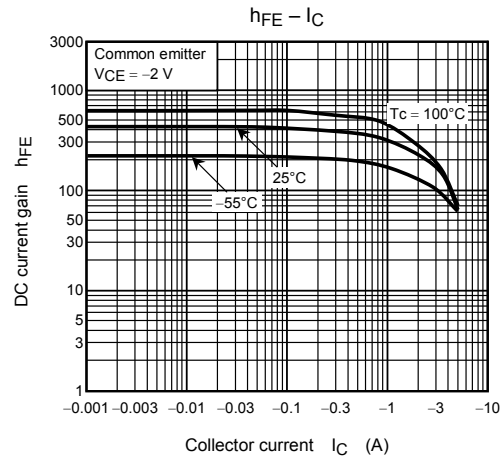
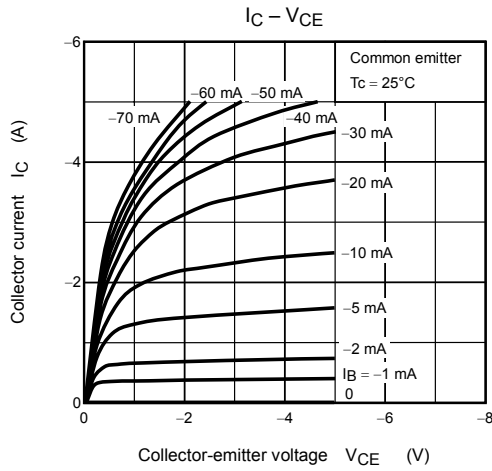
Figure 1 Switching Time Test Circuit & Timing Chart

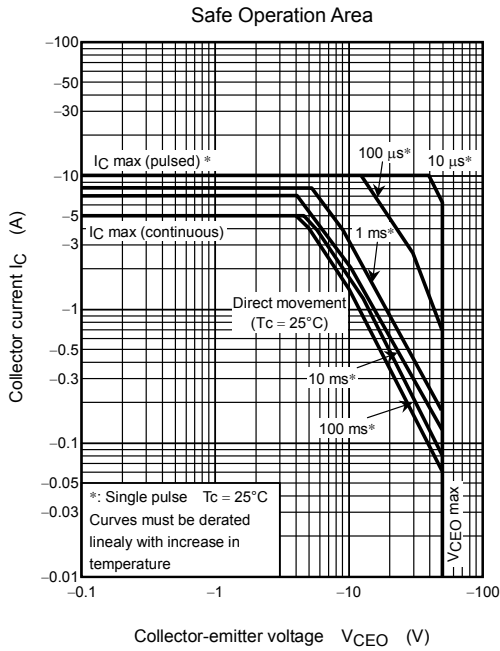
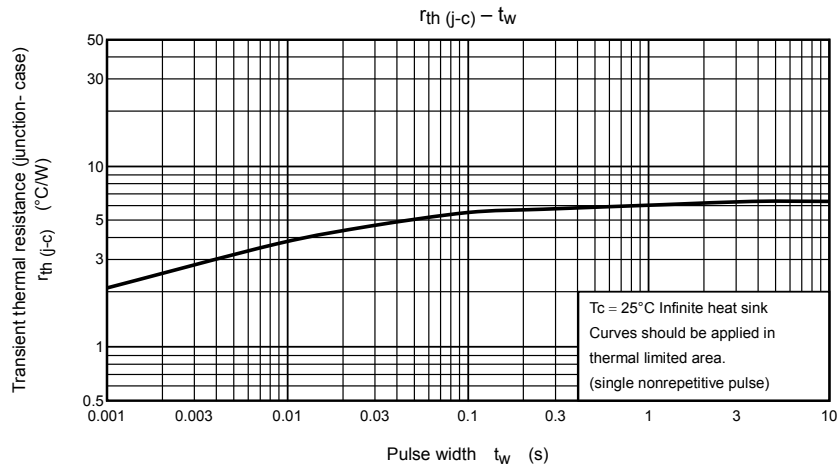
Marking



Explanation of Lot No.







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